Notice of References Cited 10/621,919 Reexamination WENGEN ET AL. Examiner Hieu Phan Reexamination WENGEN ET AL. Page 1 of 1

Application/Control No.

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,935,167	08-1999	a Wengen, Daniel F.	623/10
	В	US-			
	С	US-			
	D	US-			
-	E	US-			
	F	US-			
	G	US-			
	Η	US-			
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	7	US-			
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	L	US-	1		
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	Р					
	Q					1.30
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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